

VALEX®

DIGITAL TESTER P3500

1800146



TECHNICAL DATA

DIRECT CURRENT	SI	transistor test	NO	maximum precision	+ -2% / +2DGT
CHARACTER HEIGHT	12	field + high e.o.s.	10A	maximum precision	+ -1% / +10DGT
audio alert	SI	field + high f.d.s.	2Mohm	max precision	+ -1,2% / +10DGT
digital reading	SI	field + high e.o.s.	600V	maximum precision	+ -0,8% / +2DGT
data memory	NO	field + high f.d.s.	600V	resolution	10mA
capacity measure	NO	field + low s.d.f.	200µA	resolution	100nA
frequency measure	NO	field + low s.f.	200ohm	resolution	0,1ohm
resistance measure	SI	field + low s.d.f.	200V	resolution	1Kohm
flow rate frequency	400 Hz	field + low s.d.f.	200mV	resolution	1V
overload prot.	SI	nr of meas fields.	5	resolution	100mV
automatic scale	NO	nr of meas fields.	5	resolution	1V
thermal probe	NO	nr fields of measure.	2	resolution	0,1mV
diode test	SI	nr fields of measure.	5		

DESCRIPTION

Batteries included.

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CATALOG IMAGE



INSTRUCTION MANUAL



SPEC SHEET